

**Search Notes**

Application/Control No.

10/507,152

Examiner

Richard Edgar

Applicant(s)/Patent under  
Reexamination

BEYER ET AL.

Art Unit

3745

**SEARCHED**

Class	Subclass	Date	Examiner
415	73 90	2/15/2006	RE
416	176	2/15/2006	RE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STIC PLUS Search	2/15/2006	RE